Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/828,324	SHIN ET AL.	
Examiner	Art Unit	
Brandon J. Miller	2617	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	564	7/9/2007	ВЈМ
455	460	7/9/2007	ВЈМ
455	550.1	7/9/2007	ВЈМ
455	566	7/9/2007	ВЈМ

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East (US-PGPUB, USPAT, Derwent)	7/9/2007	ВЈМ
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